

<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/644,362	PAIST ET AL.
	Examiner	Art Unit
	Hai L. Nguyen	2816

## ISSUE CLASSIFICATION

ORIGINAL				CROSS REFERENCE(S)									
CLASS		SUBCLASS		CLASS		SUBCLASS (ONE SUBCLASS PER BLOCK)							
327		115		327		117	156						
INTERNATIONAL CLASSIFICATION				375		376							
H	0	3	K	21/00									
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Hai L. Nguyen				03/05/2005		TIMOTHY P. CALLAHAN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800				Total Claims Allowed: 20			
(Assistant Examiner)				(Date)		(Primary Examiner)				(Date)		O.G.	O.G.
Cynthia Smith 3/7/05				(Legal Instruments Examiner)		(Date)						Print Claim(s)	Print Fig.
												1	2

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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